(1005 (0402)×2 size, chip capacitor networks)

Features

Two multi-layer ceramic capacitors are integrated on a single chip providing reduced cost and mounting space.

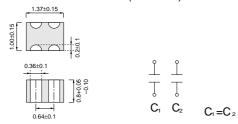
Quick Reference

The design and specifications are subject to change without prior notice. Please check the most recent technical specifications prior to placing orders or using the product. For more detail information regarding packaging style code, please check product designation.

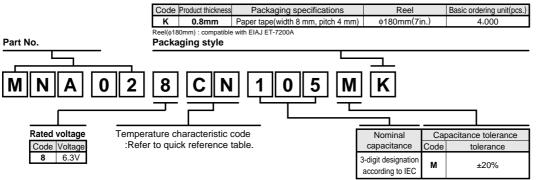
High dielectric constant

Part No.	. Size code	Temperature characteristics		Operating temp. range	Rated voltage	0	Capacitance	Thickness	
	. Size code	code		(°C)	(V)	Capacitance(pF)	tolerance	(mm)	
MNA0	1005x2 (0402x2)	CN	±15% (X5R)	-25 to +85	6.3	1,000,000	M(±20%)	0.8+0.05 -0.10	

●External dimensions (Unit : mm)



Product designation



Performance and test method

No.	Items	Performance			Test Method (As per JIS C 5101-1, JIS C 5101-10)			
1	Appearance and dimensions	No marked defects shall be allowed for appearance. Dimensions shall be as specified the clause 4.			As per 4.4 of JIS C 5101-1. As per 4.5 of JIS C 5101-10			
2	Withstanding voltage	No dielectrical breakdown or other damage shall be allowed.			As per 4.6 of JIS C 5101-1. As per 4.6.4 of JIS C 5101-10 Voltage shall be applied as per Table1. Table 1 Characteristic Voltage CN 250% Rated voltage Voltage shall be applied for 1 to 5s with 50mA charging and discharging current.			
3	Insulation resistance	Not less than 100MΩ∙ μF			As per 4.5 of JIS C 5101-1. As per 4.6.3 of JIS C 5101-10 Measurements shall be made after 60+/-5s period of the rated voltage applied.			
4	Capacitance	within +/-20%			As per 4.7 of JIS C 5101-1. As per 4.6.1 of JIS C 5101-10 Measurements shall be made under the conditions specified in Table 2. Table 2 Characteristic Frequency Voltage CN 1+/-0.1kHz 1+/-0.1Vrms.			
5	Dielectric loss tangent	tan δ≤ 10.0%			As per 4.8 of JIS C 5101-1. As per 4.6.2 of JIS C 5101-10 Measurements shall be made under the conditions specified in Table 2.			
6	Temperature characteristic	Applied voltage 0Vdc 0Vdc 3.15 Vdc	Capacitance Within +/-15% Within +/-10% Within +0/-30%	Temperature range -55°C~ +85°C -25°C~ +85°C -25°C~ +85°C	As per 4.24 of JIS C 5101-1. As per 4.7 of JIS C 5101-10 If required, measurements shall be made at a given temperature. Measurements shall be made under the conditions specified in Table 2. Table 2 Characteristic Frequency Voltage 1+/-0.1kHz 1+/-0.1Vrms.			
7	Solderability	More than 3/4 of each end termination shall be covered with new solder.			As per 4.15.2 of JIS C 5101-1. As per 4.11 of JIS C 5101-10 The solder specified in JIS Z 3282 H63A shall be used. And the flux containing 25% rosin and ethanol solution shall be used. The specimens shall be immersed into the solder at 235+/-5°C for 2+/-0.5s So that both end terminations are completely under solder.			

No.	Ite	ms	Performance	Test Method (As per JIS C 5101-1, JIS C 5101-10)			
8	Resistance to soldering	Appearance	Without mechanical damage.	As per 4.14 of JIS C 5101-1. As per 4.10 of JIS C 5101-10			
	heat	Change rate from initial value	Within +/-7.5%	The solder specified in JIS Z 3282. H63A shall be used. The specimens shall be immersed into the			
		Dielectric loss tangent	Within specified initial value.	solder at 260+/–5°C for 5+/–0.5s so that both end terminations are completely under the solder. Pre-heating at 150+/–10°C for 1 to 2min			
		Insulation resistance	Within specified initial value.	Initial measurements prior to test shall be performed after the thermal			
		Withstanding voltage	No defects shall be allowed.	Pre-conditioning specified in Remarks (1). Final measurements shall be made after the specimens have been left at room temperature as per Table3. Table 3 Characteristic Time CN 48+/-4 h			
9	End terminat adherence	ion	Without peeling or sign of peeling shall be allowed on the end terminations.	As per 4.13 of JIS C 5101-1. As per 4.8 of JIS C 5101-10 A 2N weight for 10+/-1s shall be applied to the soldered specimens as shown by the arrow mark in the below sketch.			
				Applied pressure Capacitor Substrate			
10	Bending strength Appearance		Without mechanical damage.	As per 4.35 of JIS C 5101-1. As per 4.9 of JIS C 5101-10 Glass epoxy board with soldered specimens shall be bent till 1mm by 1.0mm/s.			
11	Vibration	Appearance	Without mechanical damage.	As per 4.17 of JIS C 5101-1. The specimens shall be soldered on the			
		Change rate from initial value	Within +/-7.5%	specified test jig. Initial measurements shall be made after the thermal pre-conditioning specified in			
		Dielectric loss Within specified initial value.		Remarks(1). Final measurements shall be made after the specimens have been left at room temperature as per Table3. [Condition] Directions: 2h each X, Y and Z directions Total: 6h Frequency range: 10 to 55 to 10Hz(1min) Applitude: 1.5mm			
				(shall not exceed acceleration196m/s²) Table 3 Characteristic Time CN 48+/-4 h			

No.	Iter	ms	Performance	Test Method (As per JIS C 5101-1, JIS C 5101-10)					
12	Temperature cycling	Appearance	Without mechanical damage.	As per 4.16 of JIS C 5101-1 As per 4.12 of JIS C 5101-10					
	, ,	Change rate from initial value	Within +/-15.0%	The specimens shall be soldered on the tes jig shown in Remarks. Temperature cycle: 100cycles Initial					
		Dielectric loss tangent	Within specified initial value.	measurements prior to test shall be performed after the thermal per-conditioning specified in Remarks (1). Final measurements shall be made after the specimens have been left at room temperature as per Table3.					
		Insulation resistance	Within specified initial value.						
		Withstanding	No defects shall be allowed.	Test condition					
		voltage	The delecte chair be allewed.	Step Temp. (°C) Time (min)					
				1 Min operating temp. 30+/−3 2 Room temp. ≤3					
				2 Room temp. ≤3 3 Max operating temp. 30+/-3					
				4 Room temp. ≤3					
				Table 3					
				Characteristic Time					
				CN 48+/-4 h					
40	I I com l'allie c			A = = = 4 00 of 110 0 5404 4					
13	Humidity (Steady)	Appearance	Without mechanical damage.	As per 4.22 of JIS C 5101-1 As per JIS C 5101-10 Test temperature: 60+/-2°C Relative humidity: 90 to 95% Test time: 500 +24/-0 h Initial measurements prior to test shall be made after the voltage pre-conditioning specified in Remarks (2).					
	(Court)	Change rate from initial value	Within +/-25%						
		Dielectric tangent	Less than 200% of initial spec.						
		Insulation resistance	Not less than $10M\Omega$.	Final measurements have been left at room temperature as per Table3.					
				Characteristic Time					
				CN 48+/–4 h					
14	Humidity life test	Appearance	Without mechanical damage.	As per 4.22 of JIS C 5101-1 As per 4.14 of JIS C 5101-10 Test temperature: 60+/-2°C Relative humidity: 90 to 95% Voltage: Rated voltage Test time: 500 +24/-0 h Initial measurements prior to test shall be made after the voltage pre-conditioning specified in					
		Change rate from initial value	Within +/-25.0%						
		Dielectric loss tangent	Less than 200% of initial spec.						
		Insulation resistance Not less than $5M\Omega$.		Remarks (2). Final measurements shall be made after the specimens have been left at room temperature as per Table3. Table 3					
				Characteristic Time					
				CN 48+/-4 h					
<u> </u>									

No.	Items		Performance	(Test Method (As per JIS C 5101-1, JIS C 5101-10)				
15	Heat life test	Appearance	Without mechanical damage.	- 1	As per 4.23 of JIS C 5101-1. As per 4.15 of JIS C 5101-10				
		Change rate from initial value	Within +/-25.0%		Test Voltage		Test		
		Dielectric loss tangent	Less than 200% of initial spec.		temperature 85°C	Rated voltage	1000 +48/-0		
		Insulation resistance Not less than $10M\Omega$.	Not less than $10M\Omega$.	ma spe Fin the	Initial measurements prior to made after the voltage pre-conspecified in Remarks (2). Final measurements shall be the specimens have been leftemperature		to test sha conditioning	ng fter	
					Table 3				
					Characteris		Time -8+/-4 h		
						'		1	

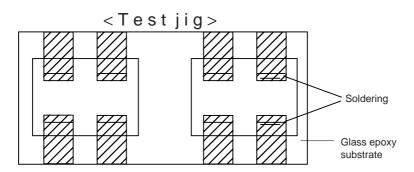
[Remarks]

Pre-conditioning

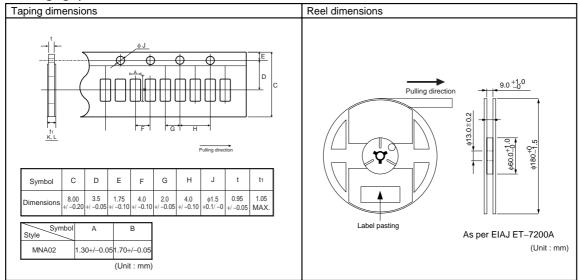
If specified in test method of as per 3(Performance and test method), capacitors of CNcharacteristics shall be pre-conditionded as follows.

- (1) Thermal pre-conditioning
 - Prior to initial measurements, specimens shall be conditioned at a temperature of 150 $\,$ 0/ -10° C for a period of 1hr., and shall be allowed to stabilize at room temperature for 48+/-4h
- (2) Voltage pre-conditioning

Prior to initial measurements, voltage specified as a test condition shall be applied to specimens for a period of 1hr., and the specimens shall be allowed to stabilize at room temperature for 48 + 7 + 4 = 100



Packaging specifications



•Electrical characteristics curves

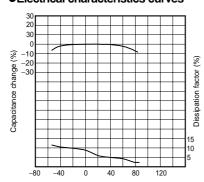


Fig.1 Temperature (°C)

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